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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/773,267	LEE ET AL.	
Examiner	Art Unit	
C. J. Arbes	3729	

SEARCHED					
Class	Subclass	Date	Examiner		
29	829	1/6/2006	CJA		
	830		Î		
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Class	Subclass	Date	Examiner	
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